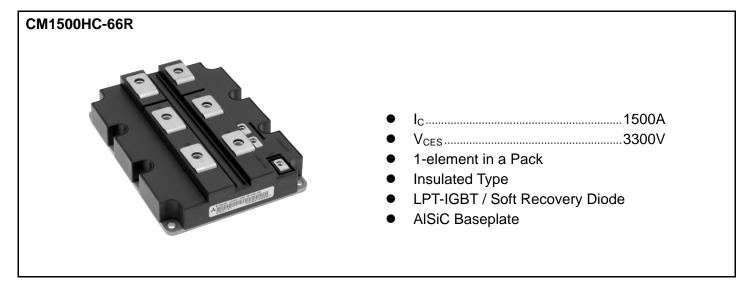


< HVIGBT MODULES > CM1500HC-66R

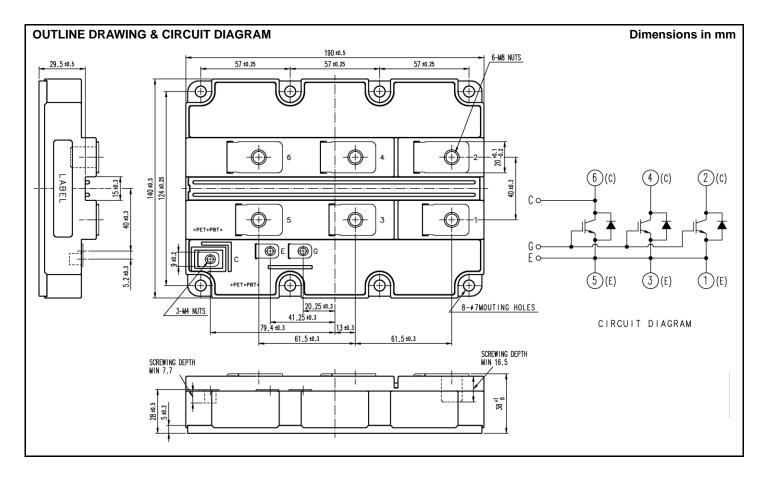
HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



< HVIGBT MODULES > CM1500HC-66R HIGH POWER SWITCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
N/	Collector omitter voltage	$V_{GE} = 0V, T_j = -40+150^{\circ}C$	3300	V
V _{CES}	Collector-emitter voltage	$V_{GE} = 0V, T_{j} = -50^{\circ}C$	3200	v
V _{GES}	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25^{\circ}C$	± 20	V
I _C	Collector current	DC, $T_c = 95^{\circ}C$	1500	А
I _{CRM}	Collector current	Pulse (Note 1)	3000	А
IE	Emitter current (Note 2)	DC	1500	А
I _{ERM}	Emitter current (Note 2)	Pulse (Note 1)	3000	А
P _{tot}	Maximum power dissipation (Note 3)	$T_c = 25^{\circ}C$, IGBT part	15600	W
V _{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	6000	V
Ve	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, $Q_{PD} \le 10 \text{ pC}$	2600	V
Tj	Junction temperature		-50 ~ +150	°C
T _{jop}	Operating junction temperature		-50 ~ +150	°C
T _{stg}	Storage temperature		-55 ~ +150	°C
t _{psc}	Short circuit pulse width	$V_{CC} = 2500V, V_{CE} \le V_{CES}, V_{GE} = 15V, T_j = 150^{\circ}C$	10	μs

ELECTRICAL CHARACTERISTICS

Oursels of	ltem	Conditions		Limits			1.1
Symbol				Min	Тур	Max	Unit
			$T_i = 25^{\circ}C$	_	_	6.0	
I _{CES}	Collector cutoff current	$V_{CE} = V_{CES}, V_{GE} = 0V$	T _i = 125°C	_	6.0		mA
			T _j = 150°C	_	36.0		
V _{GE(th)}	Gate-emitter threshold voltage	V _{CE} = 10 V, I _C = 150 mA, T _j = 25°C		5.7	6.2	6.7	V
I _{GES}	Gate leakage current	$V_{GE} = V_{GES}, V_{CE} = 0V, T_j = 25^{\circ}C$		-0.5		0.5	μA
Cies	Input capacitance				210.0	—	nF
C _{oes}	Output capacitance	V _{CE} = 10 V, V _{GE} = 0 V, f = 100 kHz T _i = 25°C			13.0		nF
Cres	Reverse transfer capacitance	$T_j = 25 C$			6.0		nF
Q_{G}	Total gate charge	V_{CC} = 1800V, I_C = 1500A, V_{GE} = ±15V			16.0	—	μC
		I _C = 1500 A ^(Note 4)	$T_j = 25^{\circ}C$		2.45		
V _{CEsat}	Collector-emitter saturation voltage	$V_{GE} = 1500 \text{ A}$ (100 s) $V_{GE} = 15 \text{ V}$	T _j = 125°C		3.10	3.70	V
		$V_{GE} = 15 V$	T _j = 150°C	_	3.25	_	
	Turn-on delay time		T _j = 25°C	—	1.00	_	μs
t _{d(on)}			T _j = 125°C	_	0.95	1.25	
			T _j = 150°C	_	0.95	1.25	
		V _{CC} = 1800 V	$T_j = 25^{\circ}C$	_	0.28		
tr	Turn-on rise time	I _C = 1500 A	T _j = 125°C	_	0.30	0.50	μs
		$V_{GE} = \pm 15 V$	T _j = 150°C	_	0.30	0.50	_
		$R_{G(on)} = 1.6 \Omega$	T _j = 25°C	_	2.10		_
E _{on(10%)}	Turn-on switching energy (Note 5)	L _s = 100 nH	T _j = 125°C	_	2.75		J
		Inductive load	T _j = 150°C	_	3.00		1
			T _j = 25°C	_	2.20		
Eon	Turn-on switching energy (Note 6)		T _i = 125°C	_	2.90		J
			T _i = 150°C	_	3.20		
			T _i = 25°C	_	2.70		
t _{d(off)}	Turn-off delay time		T _i = 125°C	_	2.80	3.30	μs
. ,			T _i = 150°C		2.85	3.30	
		V _{cc} = 1800 V	T _i = 25°C	_	0.30		
t _f	Turn-off fall time	$I_{\rm C} = 1500 {\rm A}$	T _i = 125°C	_	0.35	1.00	μs
		$V_{GE} = \pm 15 \text{ V}$	T _i = 150°C	_	0.40	1.00	1 1
		$R_{G(off)} = 5.6 \Omega$	T _j = 25°C	_	2.00		
E _{off(10%)}	Turn-off switching energy (Note 5)	$L_{s} = 100 \text{ nH}$	T _j = 125°C	_	2.45	_	J
(· · · · /	· · · · · · · · · · · · · · · · · · ·	Inductive load	T _i = 150°C		2.50	_	
		1	T _i = 25°C	_	2.20	_	
E _{off}	Turn-off switching energy (Note 6)		T _i = 125°C	_	2.70	_	J
			T _i = 150°C	_	2.80		

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

Cumhal	Item Conditions		Conditiona		Limits			Unit
Symbol				Min	Тур	Max	Unit	
	Emitter-collector voltage (Note 2)		1 1 5 0 0 A (Note 4)	T _j = 25°C	_	2.15	_	
V _{EC}		$I_E = 1500 \text{ A}^{(\text{Note 4})}$	T _j = 125°C	_	2.30	2.80	V	
			$V_{GE} = 0 V$	T _j = 150°C	_	2.25	_	
				T _j = 25°C	_	0.50	_	
t _{rr}	Reverse recovery time	(Note 2)		T _j = 125°C	_	0.70		μs
			T _j = 150°C		0.80	_		
				T _j = 25°C	_	1250		
l _{rr}	Reverse recovery current	(Note 2)	N/	T _j = 125°C	_	1500		А
		$V_{cc} = 1800 V$	T _j = 150°C		1550	_		
			$I_{\rm C} = 1500 {\rm A}$	$T_j = 25^{\circ}C$	_	1050		
Q _{rr}	Reverse recovery charge	(Note 2)	$V_{GE} = \pm 15 V$	T _j = 125°C	_	1700		μC
		$R_{G(on)} = 1.6 \Omega$	T _j = 150°C	_	2000			
	Reverse recovery energy (Note 2)	L _s = 100 nH Inductive load	T _j = 25°C		1.05	_		
E _{rec(10%)}	Reverse recovery energy	(Note 5)		T _j = 125°C	_	1.75		J
	(T _j = 150°C	_	2.00			
	Reverse recovery energy (Note 2) (Note 6)]	T _j = 25°C		1.20	_		
Erec			T _j = 125°C	_	2.00		J	
		,,		T _j = 150°C	_	2.30	_	

ELECTRICAL CHARACTERISTICS (continuation)

THERMAL CHARACTERISTICS

Symbol	Item	Conditions		Limits		
Symbol				Тур	Max	Unit
R _{th(j-c)Q}	Thermel registeres	Junction to Case, IGBT part		_	8.0	K/kW
R _{th(j-c)D}	Thermal resistance	Junction to Case, FWDi part		_	15.0	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, $\lambda_{grease} = 1W/m \cdot k$, $D_{(c-s)} = 100 \mu m$		6.0	_	K/kW

MECHANICAL CHARACTERISTICS

Symbol	ltem	Conditions	Limits			Unit
Symbol			Min	Тур	Max	Unit
Mt		M8 : Main terminals screw	7.0		22.0	N∙m
Ms	Mounting torque	M6 : Mounting screw	3.0		6.0	N∙m
Mt		M4 : Auxiliary terminals screw	1.0		3.0	N∙m
m	Mass		_	1.2	_	kg
CTI	Comparative tracking index		600			_
da	Clearance		19.5		_	mm
ds	Creepage distance		32.0		_	mm
L _{P CE}	Parasitic stray inductance		_	11.0	_	nH
R _{CC'+EE'}	Internal lead resistance	$T_{\rm C} = 25^{\circ}{\rm C}$	_	0.12	_	mΩ
r _g	Internal gate resistance	$T_{\rm C} = 25^{\circ}{\rm C}$		1.5		Ω

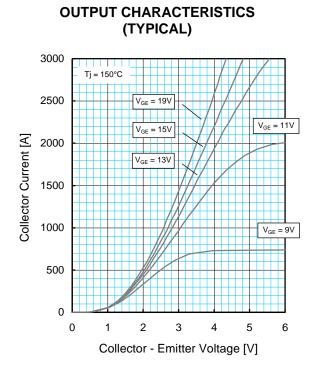
Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{opmax} rating(150°C).

2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).

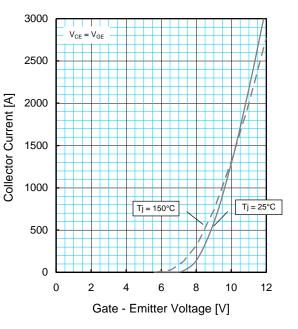
- 3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).
- 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- 5. $E_{on(10\%)}$ / $E_{off(10\%)}$ / $E_{rec(10\%)}$ are the integral of 0.1 V_{CE} x 0.1 I_C x dt.
- 6. Definition of all items is according to IEC 60747, unless otherwise specified.

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

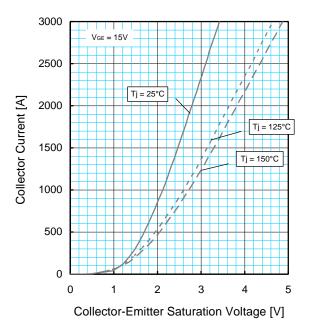
PERFORMANCE CURVES



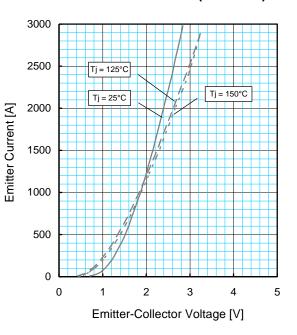
TRANSFER CHARACTERISTICS (TYPICAL)



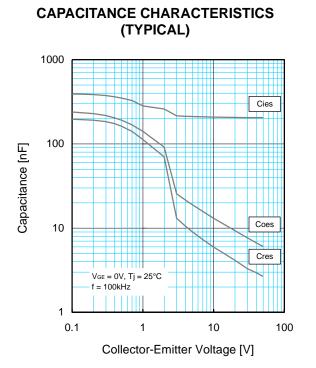
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



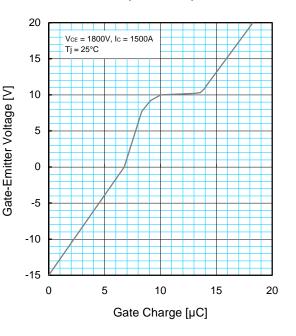
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



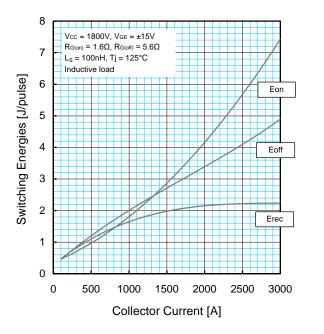
PERFORMANCE CURVES



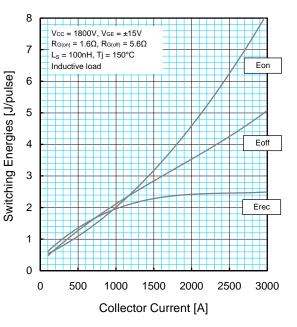
GATE CHARGE CHARACTERISTICS (TYPICAL)



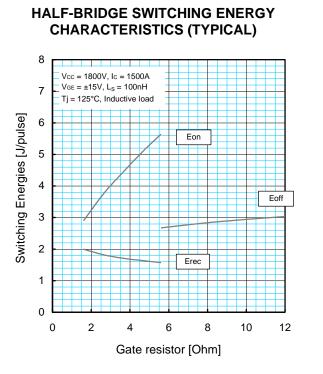
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



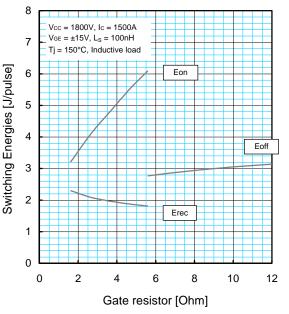
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



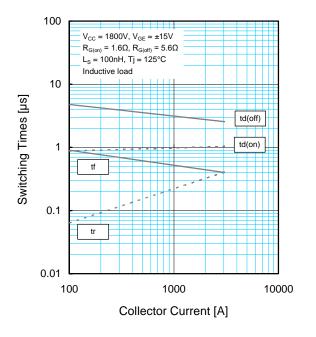
PERFORMANCE CURVES



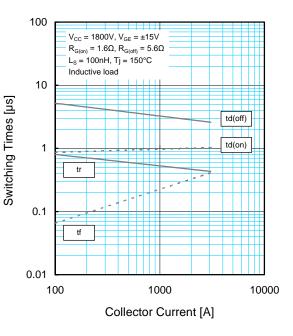
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



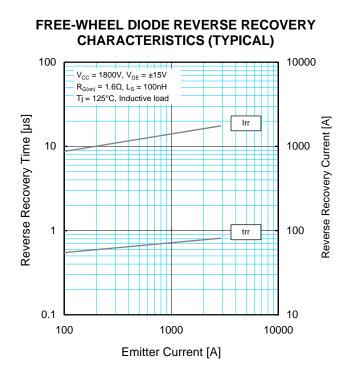
HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)

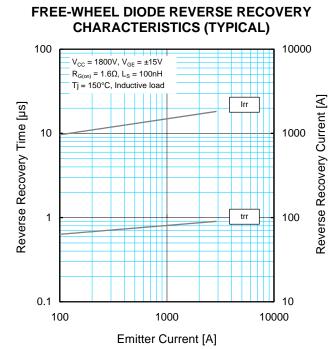


HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)

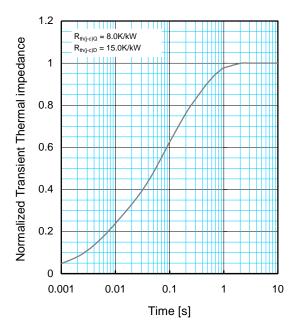


PERFORMANCE CURVES





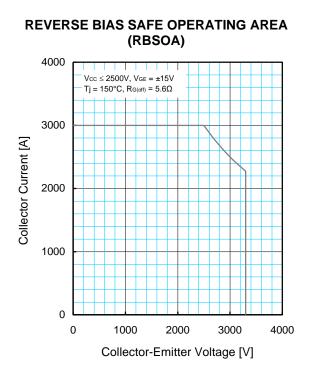
TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS

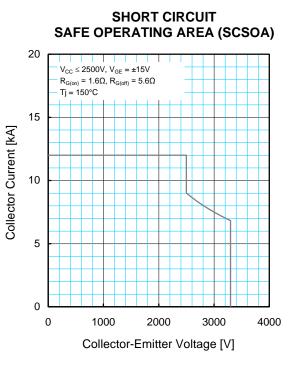


$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - \exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$								
	1	2	3	4				
R _i [K/kW] :	0.0096	0.1893	0.4044	0.3967				
τ _i [sec] :	0.0001	0.0058	0.0602	0.3512				

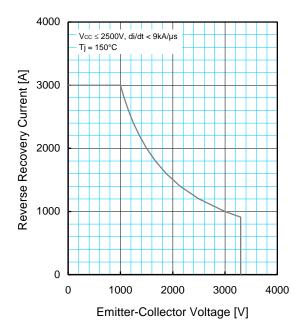
< HVIGBT MODULES > CM1500HC-66R HIGH POWER SWITCHING USE INSULATED TYPE

PERFORMANCE CURVES





FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



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